Notice of References Cited

| Application/Control No. | Applicant(s)/Pater | nt Under |
|-------------------------|---------------------------------|-------------|
| 10/804,857 | Reexamination PARIVASH, JAMS | SHID |
| Examiner | Art Unit | |
| SHARAD RAMPURIA | 2617 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | Α | US-5,566,226 | 10-1996 | Mizoguchi et al. | 455/558 |
| * | В | US-7,103,380 B1 | 09-2006 | Ditzik, Richard J. | 455/556.2 |
| * | С | US-7,107,072 | 09-2006 | Smith, Ronald L. | 455/556.2 |
| * | D | US-2002/0198021 A1 | 12-2002 | Boesen, Peter V. | 455/556 |
| * | Е | US-2004/0142725 A1 | 07-2004 | Kim, Seon-Mi | 455/556.1 |
| * | F | US-2004/0185901 A1 | 09-2004 | Kachi et al. | 455/556.1 |
| * | G | US-2007/0004450 A1 | 01-2007 | Parikh, Jay G. | 455/556.1 |
| * | Н | US-5,020,090 A | 05-1991 | Morris, Walker C. | 455/556.1 |
| * | Т | US-5,797,088 A | 08-1998 | Stamegna, Ivano | 455/345 |
| * | J | US-5,797,089 A | 08-1998 | Nguyen, Nam D. | 455/403 |
| * | к | US-5,898,758 A | 04-1999 | Rosenberg, Michael | 455/426.1 |
| * | L | US-5,907,815 A | 05-1999 | Grimm et al. | 455/557 |
| * | М | US-5,924,044 A | 07-1999 | Vannatta et al. | 455/556.1 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | т | | | | | |

NON-PATENT DOCUMENTS

| _ | NORT ALERT DOCUMENTS | | | | | |
|---|----------------------|---|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | |
| | U | | | | | |
| | v | | | | | |
| | w | | | | | |
| | × | | | | | |

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

| Application/Control No. 10/804,857 | Applicant(s)/Pate Reexamination PARIVASH, JAM | |
|---------------------------------------|---|-------------|
| Examiner SHARAD RAMPURIA | Art Unit | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | Α | US-6,233,464 B1 | 05-2001 | Chmaytelli, Mazen | 455/556.2 |
| * | В | US-6,725,060 B1 | 04-2004 | Chhatriwala et al. | 455/556.2 |
| * | C | US-6,865,401 B2 | 03-2005 | Kotzin, Michael | 455/557 |
| * | D | US-6,950,652 B2 | 09-2005 | Janssen et al. | 455/419 |
| * | Е | US-6,954,355 B2 | 10-2005 | Gerstner et al. | 361/679.09 |
| * | F | US-6,999,800 B2 | 02-2006 | Peng et al. | 455/574 |
| * | G | US-5,533,097 A | 07-1996 | Crane et al. | 455/552.1 |
| * | Н | US-5,678,229 A | 10-1997 | Seki et al. | 455/572 |
| * | - | US-7,383,061 | 06-2008 | Hawkins, Jeffrey C. | 455/556.2 |
| * | J | US-6,633,759 | 10-2003 | Kobayashi, Koichi | 455/419 |
| * | К | US-6,292,148 | 09-2001 | Matsuura et al. | 343/702 |
| * | L | US-6,188,917 | 02-2001 | Laureanti, Steven J. | 455/573 |
| * | м | US-5,974,334 | 10-1999 | Jones, Jr., James H. | 455/556.2 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | 7 |

| NON-PATENT DOCUMENTS | | | | |
|----------------------|---|---|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | |
| | U | | | |
| | v | | | |
| | w | | | |
| | x | | | |

'A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.